

Description

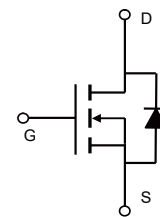
The VST10N070 uses **Super Trench** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{DS(ON)}$ and Q_g . This device is ideal for high-frequency switching and synchronous rectification.

General Features

- $V_{DS}=100V, I_D=78A$
 $R_{DS(ON)}=7.2m\Omega$ (typical) @ $V_{GS}=10V$
 $R_{DS(ON)}=9.5m\Omega$ (typical) @ $V_{GS}=4.5V$
- Excellent gate charge x $R_{DS(on)}$ product(FOM)
- Very low on-resistance $R_{DS(on)}$
- 175 °C operating temperature
- Pb-free lead plating
- 100% UIS tested

Application

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification



Schematic

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VST10N070	VST10N070-TC	TO-220	-	-	-

Absolute Maximum Ratings ($T_C=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	78	A
Drain Current-Continuous($T_C=100^{\circ}C$)	$I_D(100^{\circ}C)$	60	A
Pulsed Drain Current	I_{DM}	320	A
Maximum Power Dissipation	P_D	125	W
Derating factor		0.83	W/ $^{\circ}C$
Single pulse avalanche energy (Note 5)	E_{AS}	320	mJ
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 175	$^{\circ}C$

Thermal Characteristic

Thermal Resistance, Junction-to-Case ^(Note 2)	$R_{\theta JC}$	1.2	$^{\circ}\text{C/W}$
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Electrical Characteristics ($T_C=25^{\circ}\text{C}$ unless otherwise noted)

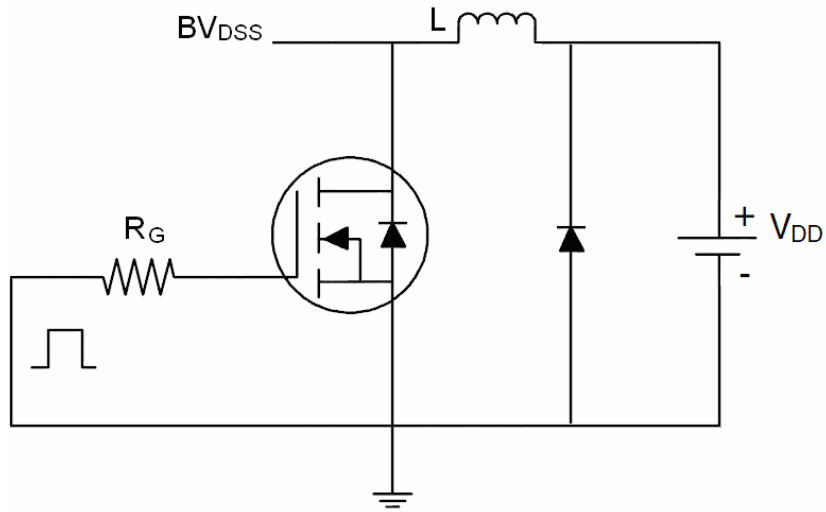
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	100		-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V, V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	1.2	1.7	2.2	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =39A	-	7.2	8.5	mΩ
		V _{GS} =4.5V, I _D =39A	-	9.5	12	mΩ
Forward Transconductance	g _{FS}	V _{DS} =10V, I _D =39A	40	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{iss}	V _{DS} =50V, V _{GS} =0V, F=1.0MHz	-	4200	5480	PF
Output Capacitance	C _{oss}		-	354	425	PF
Reverse Transfer Capacitance	C _{rss}		-	23	30	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}	V _{DD} =50V, I _D =39A V _{GS} =10V, R _G =4.7Ω	-	15	-	nS
Turn-on Rise Time	t _r		-	10	-	nS
Turn-Off Delay Time	t _{d(off)}		-	41	-	nS
Turn-Off Fall Time	t _f		-	6	-	nS
Total Gate Charge	Q _g	V _{DS} =50V, I _D =39A, V _{GS} =10V	-	65		nC
Gate-Source Charge	Q _{gs}		-	15.3		nC
Gate-Drain Charge	Q _{gd}		-	9		nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V, I _S =78A	-		1.2	V
Diode Forward Current (Note 2)	I _S		-	-	78	A
Reverse Recovery Time	t _{rr}	T _J = 25°C, I _F = I _S di/dt = 100A/μs(Note3)	-	101		nS
Reverse Recovery Charge	Q _{rr}		-	193		nC

Notes:

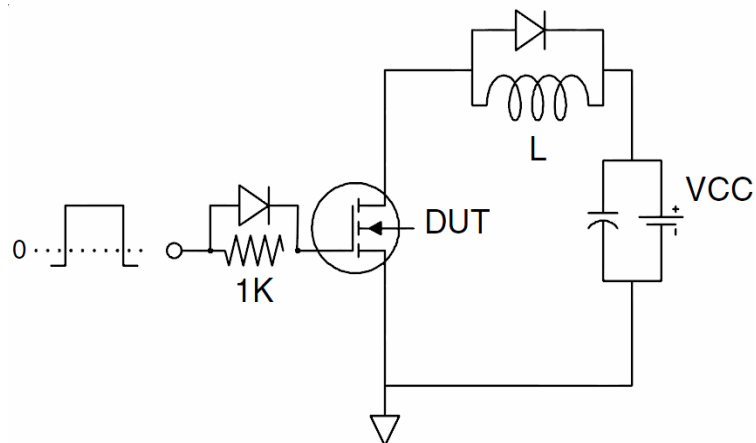
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production
5. EAS condition : $T_J=25^{\circ}\text{C}, V_{DD}=50V, V_G=10V, L=0.5mH, R_g=25\Omega$

Test Circuit

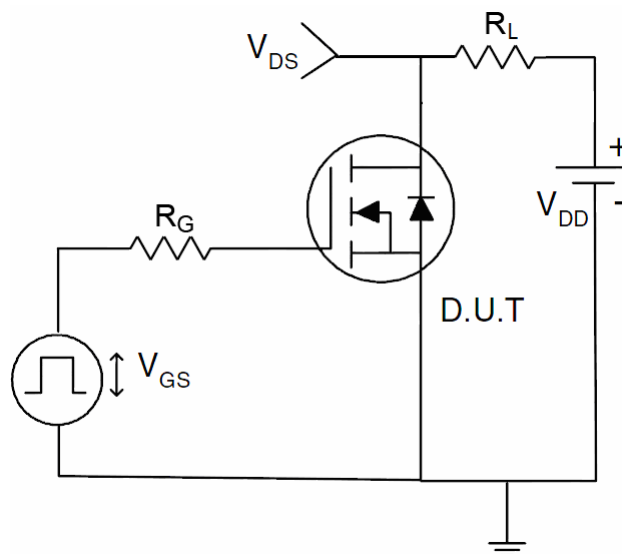
1) E_{AS} test Circuit



2) Gate charge test Circuit



3) Switch Time Test Circuit



Typical Electrical and Thermal Characteristics

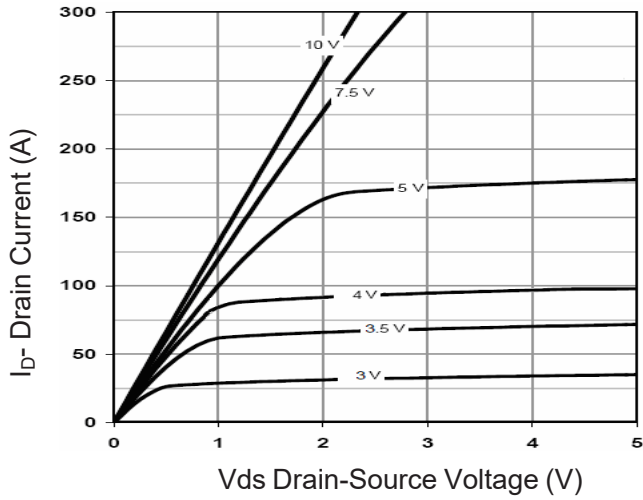


Figure 1 Output Characteristics

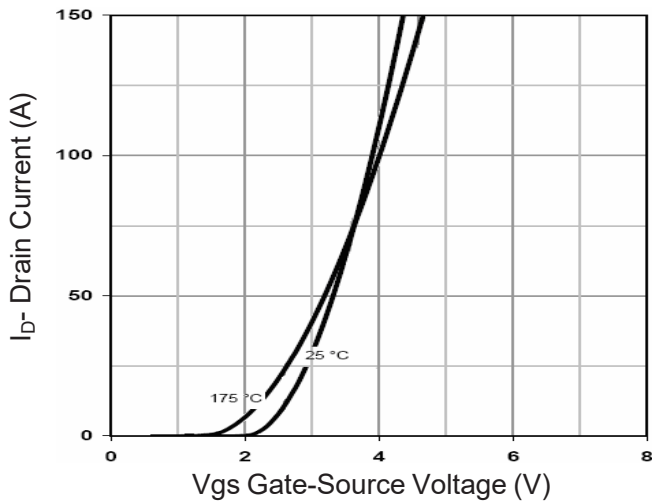


Figure 2 Transfer Characteristics

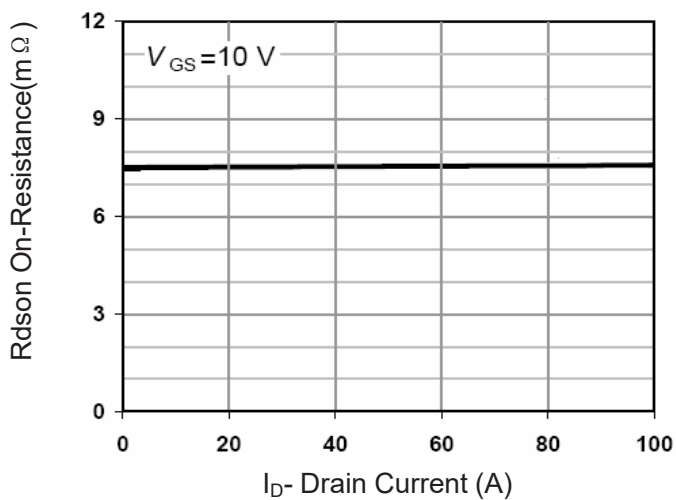


Figure 3 Rdson- Drain Current

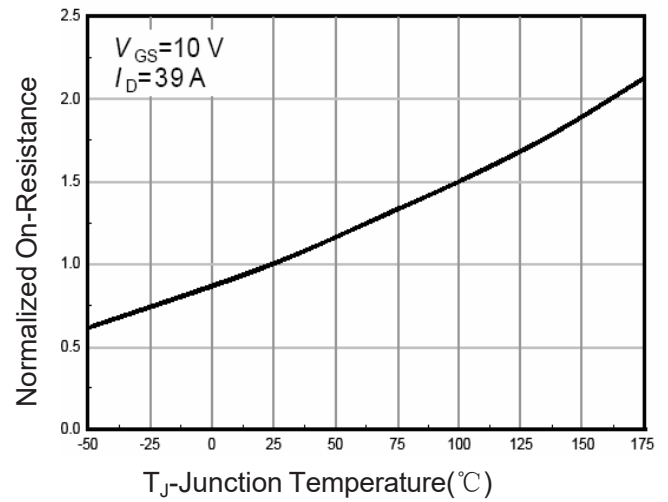


Figure 4 Rdson-Junction Temperature

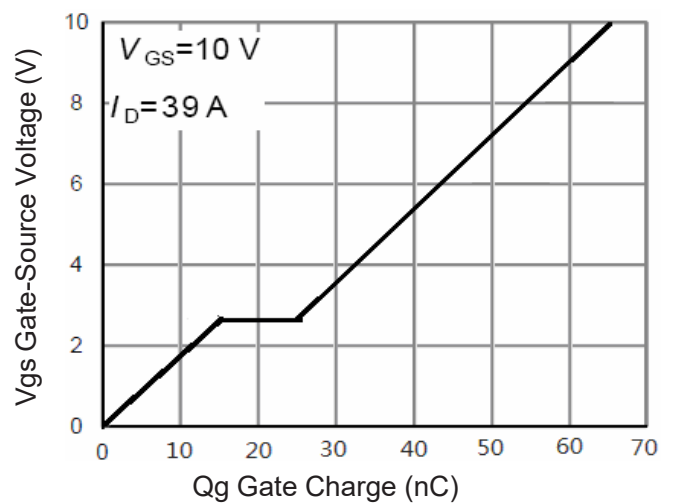


Figure 5 Gate Charge

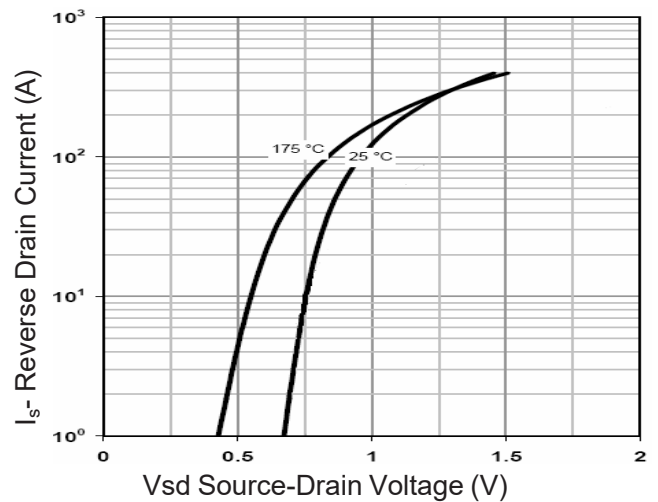
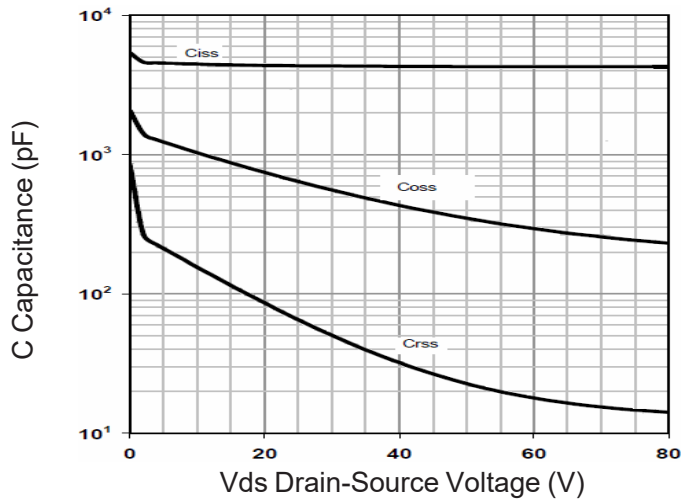
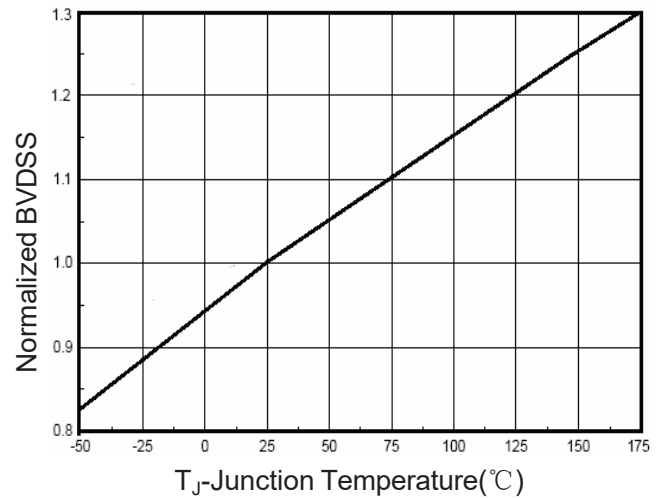
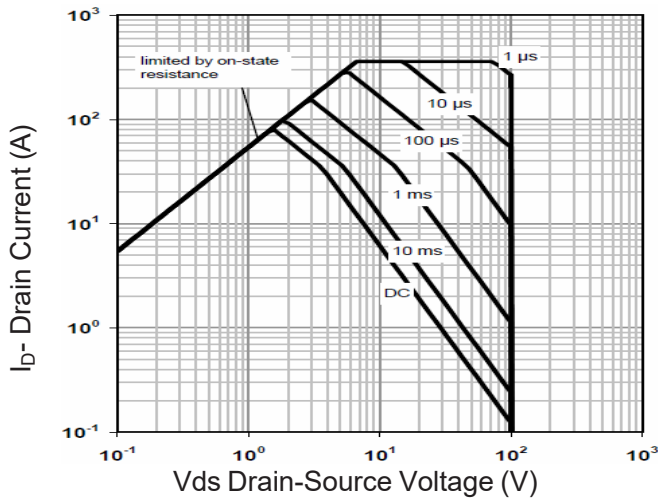
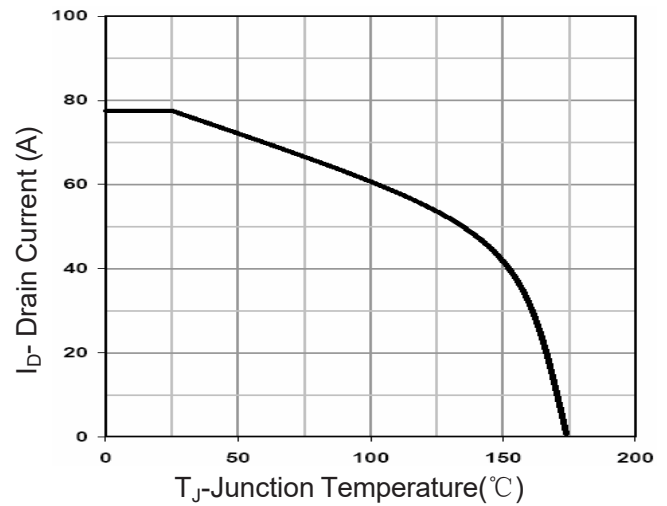
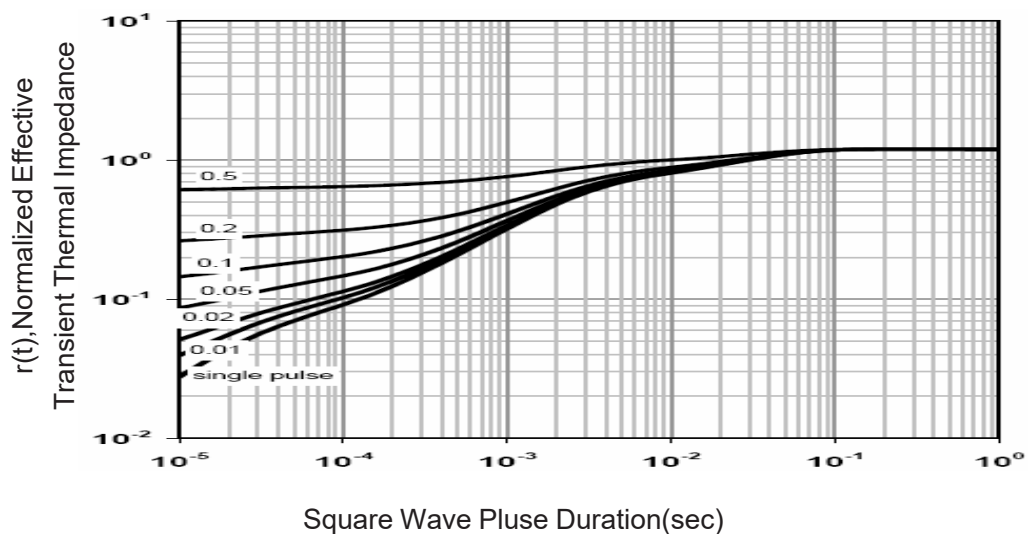


Figure 6 Source- Drain Diode Forward


Figure 7 Capacitance vs Vds

Figure 9 BV_{DSS} vs Junction Temperature

Figure 8 Safe Operation Area

Figure 10 Current De-rating

Figure 11 Normalized Maximum Transient Thermal Impedance

Reflow Curve

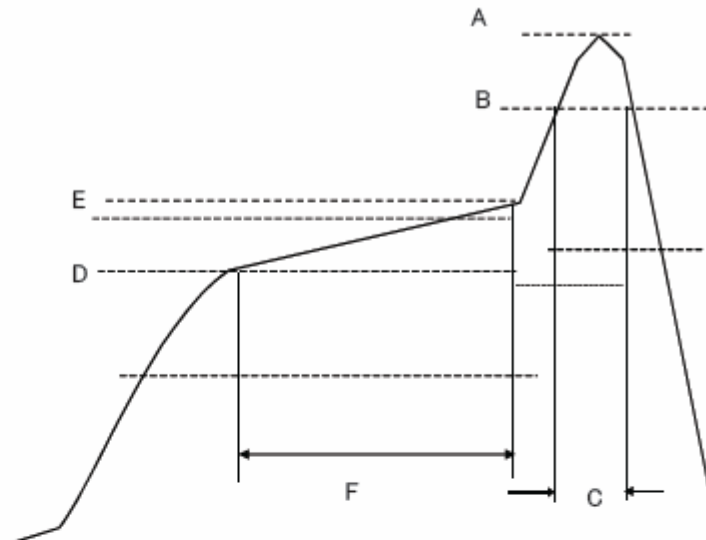
The Guarantee Letter of Parts Heat Resistance

新洁能表贴封装产品，有在以下耐热温度条件中保证的可能，建议追加到有关零件承认书的零件耐热保证项目中
(The SMD components of NCE Power have the ability of heat resistance marked below. Please add the information to corresponded items of heat resistance in Supplier Specification Submission.)

[REFLOW温度PROFILE]
(REFLOW TEMPERATURE PROFILE)

测试POINT：焊接部・part表面

A: 260±5/-0 °C
B: 217°C
C: 60~150 sec
D: 150°C
E: 200°C
F: 90±10 sec



reflow条件(次数等) (Reflow condition (times))	☒ 可用以上PROFILE进行3次 (can use the above profile for two times) ☐ 不可REFLOW (can not Reflow)		
开封后的吸湿保证 条件 (Damp resistance after opening)	☐ 无限制 (保管条件 30°C 70%RH以下) (no limit) (store condition: 30 °C 70%RH below) ☒ 开封后 30°C 60%RH168H→REFLOW (after opening)		
手焊耐热 (Soldering iron)	350±10°C 5+1/-0 sec	flow耐热 (flow heat-resistant)	270±3°C 10+1/-0 sec
Pb含有状况 (Pb content status)	零件外部 (external)	☒ Pb完全无使用 Pb-free ☐ Pb有使用其位置 (无铅化予定 年 月) Pb used in location (realize Pb-free year month)	
	零件内部 (inside)	☐ Pb完全无使用 Pb-free ☒ Pb有使用其位置 (内部电极含有Pb, 无铅化予定 年 月) Pb used in the inside electrodes (realize Pb-free year month)	
	电极镀层的组成 (Composition of lead cladding)	☒ Sn, ☐ Sn-Cu, ☐ Sn-Ag, ☐ Sn-Bi, ☐ 其他(other)() ☐ Sn-Pb (无铅化予定 年 月) (realize Pb-free year month)	
	无铅区分 (Pb-free manage)	☐ 料号变更 (无铅零件料号: ABC12345) P/N changed (Pb-free P/N:) ☒ 料号不变,自然切换 (切换时间点: 年 月 日) P/N not changed,switch naturally (switch time: year month date)	

Solder Dip

260°C /10Sec Whole body